## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10751436	LEE ET AL.
Fxaminer	Art Unit

2617

SEARCHED					
Class	Subclass	Date	Examiner		
370	401, 328, 351	3/12/08	СТ		
455	433	3/12/08	СТ		
370	352-356	10/10/08	CT		
370	313, 349	7/01/09	CT		

CongVan Tran

SEARCH NOTES		
Search Notes	Date	Examiner
Search updated	7/01/09	CT

		INTERFERENCE SEARCH		
Class		Subclass	Date	Examiner
370	349		7/01/09	CT

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